



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Lawrence C. Lei et al.

Serial No.: 10/685,210

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For: METHOD AND APPARATUS FOR DYNAMICALLY MEASURING THE THICKNESS OF AN OBJECT (as amended)

Art Unit: 2862

Examiner: Jay M. Patidar

CERTIFICATE UNDER 37 C.F.R. § 1.8(a)

I hereby certify that this correspondence, and any enclosures referenced herein, is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents, PO Box 1450, Alexandria, VA 22313-1450 on

1/3, 2006.



Jody Begley

Commissioner for Patents
PO Box 1450
Alexandria, VA 22313-1450

AMENDMENT

In response to the office action dated August 10, 2005, please amend the above-referenced patent application as follows:

Amendments to the Claims begin on page 2 of this paper.

Remarks begin on page 9 of this paper.